

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of:

Atsuo OUMIYA et al.

Appln. No.:

Group Art Unit:

Filed: HERewith

For: SEMICONDUCTOR DEVICE AND A METHOD OF TESTING THEREOF

* * *

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Pursuant to 37 C.F.R. § 1.56, and without any assertion as to materiality or prior art effect, the documents listed on the attached Form PTO-1449 are hereby cited.

Documents AJ-AN on the attached List were cited in the specification, on page 1, and their relevance is indicated therein.

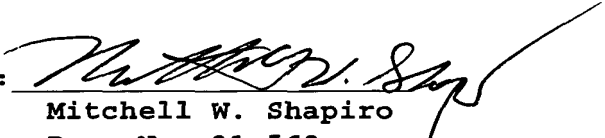
Documents AA-AD correspond, respectively, to Documents AJ-AM.

Respectfully submitted,

MWS:lat

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July 9, 2003

FORM PTO-1449				Atty. Docket No. XA-9866		Appln. No.	
LIST OF DOCUMENTS CITED BY APPLICANT							
				Applicant Atsuo OUMIYA et al.			
				Filing Date HEREWITH		Group	
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date
	AA	5,619,460	4/8/97	Kirihata et al.	365	201	
	AB	5,615,164	3/25/97	Kirihata et al.	365	230.06	
	AC	6,084,808	7/4/00	Lim et al.	365	201	
	AD	5,657,282	8/12/97	Lee	365	201	
	AE						
	AF						
	AG						
	AH						
	AI						
FOREIGN PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation
	AJ	08-339696	12/24/96	Japan			Abstract
	AK	08-339699	12/24/96	Japan			Abstract
	AL	11-238397	08/31/99	Japan			Abstract
	AM	07-262798	10/13/95	Japan			Abstract
	AN	08-273394	10/18/96	Japan			Abstract
	AO						
OTHER (including author, title, date, pertinent pages, etc.)							
	AP						
	AQ						
	AR						
Examiner				Date Considered			
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							